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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/718,445	11/19/2003	Sandeep Bhatia	CA7035962001	9844
23639 759	90 10/20/2006	•	EXAM	INER
BINGHAM, MCCUTCHEN LLP			TABONE JR, JOHN J	
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SAN FRANCISCO, CA 94111-4067			2138	
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Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(s)
-	10/718,445	BHATIA, SANDEEP
Office Action Summary	Examiner	Art Unit
	John J. Tabone, Jr.	2138
The MAILING DATE of this communication ap	opears on the cover sheet w	ith the correspondence address
Period for Reply A SHORTENED STATUTORY PERIOD FOR REPL WHICHEVER IS LONGER, FROM THE MAILING I - Extensions of time may be available under the provisions of 37 CFR 1 after SIX (6) MONTHS from the mailing date of this communication. - If NO period for reply is specified above, the maximum statutory period. - Failure to reply within the set or extended period for reply will, by statu	DATE OF THIS COMMUNION (136(a). In no event, however, may a lid will apply and will expire SIX (6) MON	CATION. reply be timely filed ITHS from the mailing date of this communication.
Any reply received by the Office later than three months after the maili earned patent term adjustment. See 37 CFR 1.704(b).	ing date of this communication, even if	timely filed, may reduce any
Status		
 1) Responsive to communication(s) filed on 31. 2a) This action is FINAL. 2b) Th 3) Since this application is in condition for allow closed in accordance with the practice under 	is action is non-final. ance except for formal matt	•
Disposition of Claims		
4)	awn from consideration.	
Application Papers		
9) ☐ The specification is objected to by the Examin 10) ☑ The drawing(s) filed on 19 November 2003 is Applicant may not request that any objection to the Replacement drawing sheet(s) including the correct 11) ☐ The oath or declaration is objected to by the E	/are: a)⊠ accepted or b) e drawing(s) be held in abeyar ction is required if the drawing	nce. See 37 CFR 1.85(a). (s) is objected to. See 37 CFR 1.121(d).
Priority under 35 U.S.C. § 119		
12) Acknowledgment is made of a claim for foreig a) All b) Some * c) None of: 1. Certified copies of the priority documer 2. Certified copies of the priority documer 3. Copies of the certified copies of the priority application from the International Burea * See the attached detailed Office action for a list	nts have been received. nts have been received in A ority documents have been au (PCT Rule 17.2(a)).	pplication No received in this National Stage
Attachment(s) 1) \(\sum \) Notice of References Cited (PTO-892) 2) \(\sum \) Notice of Draftsperson's Patent Drawing Review (PTO-948)	Paper No(s	Summary (PTO-413) s)/Mail Date
3) Information Disclosure Statement(s) (PTO/SB/08) Paper No(s)/Mail Date 07312006, 09212006.	5) Notice of I	nformal Patent Application —-

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DETAILED ACTION

1. Claims 1-23 are pending in the current application and have been examined. Claims 1, 5, 7-8, 10-11, 15, 17-18, and 20-21 have been amended.

2. The 35 USC § 112, second paragraph rejections have been withdrawn by the Examiner as a result of Applicant's amendments filed 07/31/2006.

Information Disclosure Statement

3. The information disclosure statements (IDS) submitted on 07/31/2006 and 09/21/2006 were filed after the mailing date of the Non-Final Office Action on 03/15/2006. The submission is in compliance with the provisions of 37 CFR 1.97. Accordingly, the information disclosure statement is being considered by the examiner.

Response to Arguments

4. Applicant's arguments with respect to independent claims 1, 11 and 21 have been considered but are most in view of the new ground(s) of rejection.

Claim Rejections - 35 USC § 112

The following is a quotation of the second paragraph of 35 U.S.C. 112:

The specification shall conclude with one or more claims particularly pointing out and distinctly claiming the subject matter which the applicant regards as his invention.

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5. Claims 1-23 are rejected under 35 U.S.C. 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention.

Claims 1, 11 and 21:

The claim limitation "the clock cycle is directly input..." renders these claims indefinite because it is not clear how a "clock cycle" is input to scan chains. The term "clock cycle" is typically in reference to the time or the period of a clock source and it cannot be directly connected to anything. Clarification and correction is required.

Claims 2-10, 12-20, and 22-23:

These claims are also rejected because they depend on Claims 1, 11 and 21, respectively, and have the same problems of indefiniteness.

Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (a) the invention was known or used by others in this country, or patented or described in a printed publication in this or a foreign country, before the invention thereof by the applicant for a patent.
- 6. Claims 1-5, 11-15 and 21-23 are rejected under 35 U.S.C. 102(a) as being anticipated by Masatake (JP-2003-202362), hereinafter Masatake.

Claims 1, 11 and 21:

Masatake teaches scanning a first test data from an input pin (IN1, Drawing 1) into a first scan chain (Shift Register 11, Drawing 1) during a first state of a clock cycle

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(T3, Drawing 3) and scanning a second test data from the input pin (IN1, Drawing 1) into a second scan chain (Shift Register 12, Drawing 1) during a second state of the clock cycle (T4, Drawing 3). Masatake also teaches "the clock cycle is directly input to the first scan chain and the second scan chain during testing" in claim 1 and 2 where Masatake discloses "Said 1st shift register which operates synchronizing with the 1st edge of **said scanning clock**, said 2nd shift register which operates synchronizing with the 2nd edge of **said scanning clock**" (claim 1) where "said 1st edge being the rising edge and said 2nd edge being a falling edge" (claim 2). (Abstract, ¶s 37, 38, 47, 49, Drawings 1 and 3).

Claims 2, 12 and 22:

Masatake teaches receiving test data from the first scan chain at an output pin (OUT1, Drawing 1) during the first state of the clock cycle (T3, Drawing 3). (Abstract, ¶s 37, 38, 47, 49, Drawings 1 and 3).

Claims 3, 13 and 23:

Masatake teaches receiving test data from the second scan chain at the output pin (OUT2, Drawing 1) during the second state of the clock cycle (T4, Drawing 3). (Abstract, ¶s 37, 38, 47, 49, Drawings 1 and 3).

Claims 4 and 14:

Masatake teaches sending test data from the first and second scan chains (Shift Register 11 and 12, Drawing 1) to a multiplexor (multiplexer 41, Drawing 1), applying a select signal to the multiplexor based on the state of the clock signal (CLK), and causing the multiplexor to output test data from either the first or second scan chain to the output

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pin based on the select signal (SCO1, Drawings 1 and 3). (Abstract, ¶s 37, 38, 47, 49, Drawings 1 and 3).

Claims 5 and 15:

Masatake teaches scanning the first test data by using a return-to-one clock waveform (T3, T4, T5, Drawing 3) and using positive edge triggered scan flip-flops in the first scan chain (Drawing 2). Masatake also teaches scanning the second test data by using the return-to-one clock waveform (T3, T4, T5, Drawing 3) and using positive edge triggered scan flip-flops in the second scan chain (Drawing 2). (Abstract, ¶s 37, 38, 47, 49, Drawings 1-3).

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

- (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 7. Claims 8 and 18 are rejected under 35 U.S.C. 103(a) as being unpatentable over Masatake (JP-2003-202362), hereinafter Masatake.

Claims 8 and 18:

These claims are an obvious alternate representation of claims 5 and 15 and, as such, are rejected as per these rejections. To use a return-to-zero selection criteria instead of return-to-one selection criteria is considered an alternate design choice.

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8. Claims 6, 9, 16 and 19 are rejected under 35 U.S.C. 103(a) as being unpatentable over Masatake (JP-2003-202362), hereinafter Masatake, in view of Jaramillo et al., (10 Tips for Successful Scan Design: Part two, February 17, 2000, ednmag.com, pp. 77-90), hereinafter Jaramillo.

Claims 6 and 16:

Masatake does not explicitly teach "associating a lockup register with a beginning flip-flop or an ending flip-flop of the first or second scan chains based on return-to-one selection criteria". Jaramillo teaches in an analogous art the general use of using a lockup register with a beginning flip-flop or an ending flip-flop of two separate scan chains. (Fig. 3, page 82). It would have been obvious to one of ordinary skill in the art at the time the invention was made to modify Masatake's design of Drawing 1 to include Jaramillo's design suggestions of using lockup latches when interfacing positive and negative edge clock scan flip-flops. The artisan would be motivated to do so because it would prevent Masatake's design of Drawing 1 from shifting data through both edged flip-flops in on clock cycle.

Claims 9 and 19:

These claims are an obvious alternate representation of claims 6 and 16 and, as such, are rejected as per these rejections. To use a return-to-zero selection criteria instead of return-to-one selection criteria is considered an alternate design choice.

9. Claims 7, 10, 17 and 20 are rejected under 35 U.S.C. 103(a) as being unpatentable over Masatake (JP-2003-202362), hereinafter Masatake, in view of

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Jaramillo et al., (10 Tips for Successful Scan Design: Part two, February 17, 2000, ednmag.com, pp. 77-90), hereinafter Jaramillo, in further view of Morton (US 20040078741), hereinafter Morton.

Claims 7 and 17:

Masatake in view of Jaramillo does not explicitly teach "associating a negative edge triggered scan-in lockup register with the beginning flip-flop of the first scan chain if the beginning flip-flop of the first scan chain has a positive edge trigger", "associating a positive edge triggered scan-in lockup register with the beginning flip-flop of the second scan chain if the beginning flip-flop of the second scan chain has a negative edge trigger" and "associating a negative edge triggered scan-out lockup register if the ending flip-flop of the second scan chain has a negative edge trigger". However, Masatake in view of Jaramillo does teaches the general use of using a lockup register with a beginning flip-flop or an ending flip-flop of two separate scan chains to prevent a shoot-through condition. (Fig. 3, page 82). Morton teaches in an analogous art associating a negative edge triggered scan-in lockup register with the beginning flipflop of the first scan chain if the beginning flip-flop of the first scan chain has a positive edge trigger". (Fig. 2, ¶ 21). It would have been obvious to one of ordinary skill in the art at the time the invention was made to modify lockup latch configuration of Masatake in view of Jaramillo with Morton's design of Fig. 2. The artisan would be motivated to do so because it would enable the lockup latch configuration of Masatake in view of Jaramillo to present input data IN1 of Drawing 1 to the input of scan chain 11 on the inactive portion of the clock, thus preventing shoot-through. Also, the claim limitations

"associating a positive edge triggered scan-in lockup register with the beginning flip-flop of the second scan chain if the beginning flip-flop of the second scan chain has a negative edge trigger" and "associating a negative edge triggered scan-out lockup register if the ending flip-flop of the second scan chain has a negative edge trigger" are obvious design choices given the above mentioned modification to Masatake in view of Jaramillo.

Claims 10 and 20:

These claims are an obvious alternate representation of claims 7 and 17 and, as such, are rejected as per these rejections. To use a *positive edge* triggered scan-in lockup register with a *negative edge* trigger beginning flip-flop of the first scan chain instead of a *negative edge* triggered scan-in lockup register with a *positive edge* trigger beginning flip-flop of the first scan chain is considered an alternate design choice.

Conclusion

Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the

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shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the date of this final action.

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Any inquiry concerning this communication or earlier communications from the examiner should be directed to John J. Tabone, Jr. whose telephone number is (571) 272-3827. The examiner can normally be reached on M-F.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Albert DeCady can be reached on (571) 272-3819. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

lonn J. Tabone, Jr.

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SUPERVISORY PATENT EXAMINER
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